
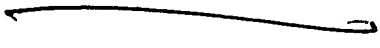

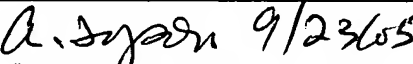


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/020,336	HACK ET AL.	
	Examiner	Art Unit	
	Tu X. Nguyen	2684	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
455	566			379	447				
INTERNATIONAL CLASSIFICATION									
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 (Assistant Examiner) (Date)		 <b>NAY MAUNG</b> SUPERVISORY PATENT EXAMINER (Primary Examiner)		Total Claims Allowed: 51	
 (Legal Instruments Examiner) (Date)		(Date)		O.G. Print Claim(s) 1	O.G. Print Fig. 2

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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